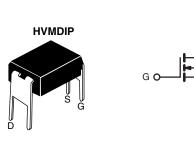


Power MOSFET

| PRODUCT SUMMARY | | | | | |
|----------------------------|------------------------|------|--|--|--|
| V _{DS} (V) | 100 | | | | |
| $R_{DS(on)}(\Omega)$ | V _{GS} = 10 V | 0.54 | | | |
| Q _g (Max.) (nC) | 8.3 | | | | |
| Q _{gs} (nC) | 2.3 | | | | |
| Q _{gd} (nC) | 3.8 | | | | |
| Configuration | Single | | | | |



N-Channel MOSFET

FEATURES

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- For Automatic Insertion
- End Stackable
- 175 °C Operating Temperature
- Fast Switching and Ease of Paralleling
- Compliant to RoHS Directive 2002/95/EC

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The 4 pin DIP package is a low cost machine-insertable case style which can be stacked in multiple combinations on standard 0.1" pin centers. The dual drain serves as a thermal link to the mounting surface for power dissipation levels up to 1 W.

| ORDERING INFORMATION | |
|----------------------|-------------|
| Package | HVMDIP |
| Lead (Pb)-free | IRFD110PbF |
| | SiHFD110-E3 |
| SnPb | IRFD110 |
| | SiHFD110 |

| PARAMETER | | | SYMBOL | LIMIT | UNIT | |
|--|-------------------------|-------------------------|-----------------------------------|------------------|---------------------------------------|--|
| Drain-Source Voltage | | | V _{DS} | 100 | \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ | |
| Gate-Source Voltage | | | V _{GS} | ± 20 | V | |
| Continuous Drain Current | V _{GS} at 10 V | T _A = 25 °C | 1- | 1.0 | А | |
| Continuous Drain Current | | T _A = 100 °C | I _D | 0.71 | | |
| Pulsed Drain Current ^a | | | I _{DM} | 8.0 | 1 | |
| Linear Derating Factor | | | | 0.0083 | W/°C | |
| Single Pulse Avalanche Energy ^b | | | E _{AS} | 140 | mJ | |
| Repetitive Avalanche Current ^a | | | I _{AR} | 1.0 | А | |
| Repetitive Avalanche Energy ^a | | | E _{AR} | 0.13 | mJ | |
| Maximum Power Dissipation T _A = 25 °C | | P _D | 1.3 | W | | |
| Peak Diode Recovery dV/dt ^c | | | dV/dt | 5.5 | V/ns | |
| Operating Junction and Storage Temperature Range | | | T _J , T _{stg} | - 55 to + 175 | 0.0 | |
| Soldering Recommendations (Peak Temperature) | for 10 s | | | 300 ^d | °C | |

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. $V_{DD} = 25 \text{ V}$, starting $T_J = 25 \,^{\circ}\text{C}$, $L = 52 \,^{\circ}\text{MH}$, $R_g = 25 \,^{\circ}\Omega$, $I_{AS} = 2.0 \,^{\circ}\text{A}$ (see fig. 12).
- c. $I_{SD} \le 5.6$ A, $dI/dt \le 75$ A/ μ s, $V_{DD} \le V_{DS}$, $T_J \le 175$ °C.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply

IRFD110, SiHFD110

Vishay Siliconix



| THERMAL RESISTANCE RATINGS | | | | | |
|-----------------------------|------------|------|------|------|--|
| PARAMETER | SYMBOL | TYP. | MAX. | UNIT | |
| Maximum Junction-to-Ambient | R_{thJA} | - | 120 | °C/W | |

| PARAMETER | nless otherw SYMBOL | TES | MIN. | TYP. | MAX. | UNIT | |
|---|----------------------------------|---|--|------|------|-------|------------------|
| Static | | | | L | | | |
| Drain-Source Breakdown Voltage | V _{DS} | V _{GS} = 0 V, I _D = 250 μA | | 100 | - | - | V |
| V _{DS} Temperature Coefficient | ΔV _{DS} /T _J | Reference | ce to 25 °C, I _D = 1 mA | - | 0.12 | - | V/°C |
| Gate-Source Threshold Voltage | V _{GS(th)} | V _{DS} = | = V _{GS} , I _D = 250 μA | 2.0 | - | 4.0 | V |
| Gate-Source Leakage | I _{GSS} | | V _{GS} = ± 20 V | - | - | ± 100 | nA |
| | I _{DSS} | V _{DS} = | V _{DS} = 100 V, V _{GS} = 0 V | | - | 25 | |
| Zero Gate Voltage Drain Current | | V _{DS} = 80 V | , V _{GS} = 0 V, T _J = 150 °C | - | - | 250 | μA |
| Drain-Source On-State Resistance | R _{DS(on)} | V _{GS} = 10 V | I _D = 0.60 A ^b | - | _ | 0.54 | Ω |
| Forward Transconductance | 9 _{fs} | $V_{DS} = 50 \text{ V}, I_D = 0.60 \text{ A}^b$ | | 0.80 | - | - | S |
| Dynamic | | | | 1 | | | |
| Input Capacitance | C _{iss} | V 0V | | - | 180 | - | pF |
| Output Capacitance | C _{oss} | | $V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$ $f = 1.0 \text{ MHz}, \text{ see fig. } 5$ | | 81 | - | |
| Reverse Transfer Capacitance | C _{rss} | f = 1 | | | 15 | - | |
| Total Gate Charge | Qg | | | - | - | 8.3 | nC |
| Gate-Source Charge | Q _{gs} | V _{GS} = 10 V | $V_{GS} = 10 \text{ V}$ $I_D = 5.6 \text{ A}, V_{DS} = 80 \text{ V},$ see fig. 6 and 13 ^b | | - | 2.3 | |
| Gate-Drain Charge | Q _{gd} | 1 | See fig. 6 and 16 | - | - | 3.8 | |
| Turn-On Delay Time | t _{d(on)} | $V_{DD} = 50 \text{ V}, I_{D} = 5.6 \text{ A},$ $R_{g} = 24 \Omega, R_{D} = 8.4 \Omega, \text{ see fig. } 10^{b}$ | | - | 6.9 | - | ns |
| Rise Time | t _r | | | - | 16 | - | |
| Turn-Off Delay Time | t _{d(off)} | | | - | 15 | - | |
| Fall Time | t _f | | | - | 9.4 | - | |
| Internal Drain Inductance | L _D | Between lead, 6 mm (0.25") from package and center of die contact | | - | 4.0 | - | -11 |
| Internal Source Inductance | L _S | | | - | 6.0 | - | - nH |
| Drain-Source Body Diode Characteristic | s | | | | l | · | |
| Continuous Source-Drain Diode Current | I _S | MOSFET symbol showing the integral reverse p - n junction diode | | - | - | 1.0 | _ |
| Pulsed Diode Forward Current ^a | I _{SM} | | | - | - | 8.0 | A |
| Body Diode Voltage | V_{SD} | $T_J = 25 ^{\circ}\text{C}, I_S = 1.0 \text{A}, V_{GS} = 0 \text{V}^{\text{b}}$ | | - | - | 2.5 | V |
| Body Diode Reverse Recovery Time | t _{rr} | T _J = 25 °C, I _F = 5.6 A, dI/dt = 100 A/μs ^b | | - | 100 | 200 | ns |
| Body Diode Reverse Recovery Charge | Q _{rr} | | | - | 0.44 | 0.88 | μC |
| Forward Turn-On Time | t _{on} | Intrinsic turn-on time is negligible (turn-on is dominated by L _S and L _D) | | | | | L _D) |

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width \leq 300 µs; duty cycle \leq 2 %.





TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

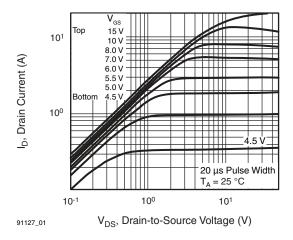


Fig. 1 - Typical Output Characteristics, T_A = 25 °C

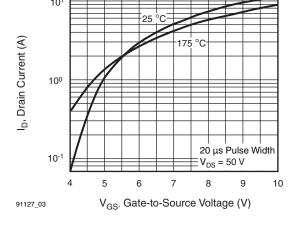


Fig. 3 - Typical Transfer Characteristics

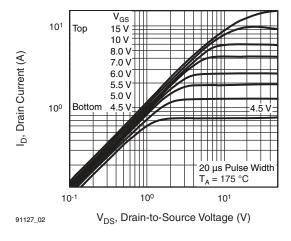


Fig. 2 - Typical Output Characteristics, T_A = 175 °C

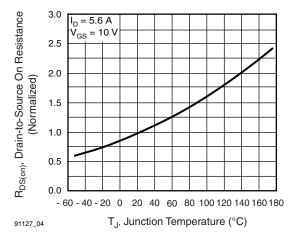


Fig. 4 - Normalized On-Resistance vs. Temperature



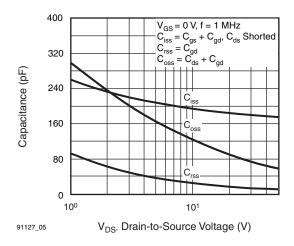


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

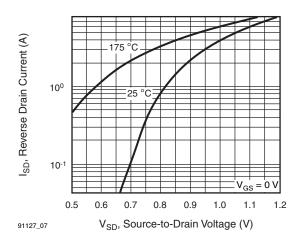


Fig. 7 - Typical Source-Drain Diode Forward Voltage

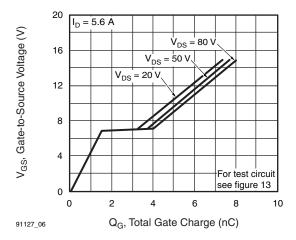


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

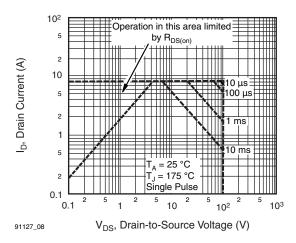


Fig. 8 - Maximum Safe Operating Area





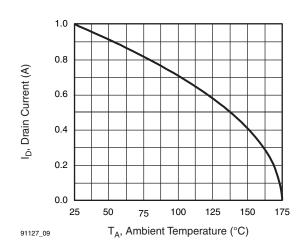


Fig. 9 - Maximum Drain Current vs. Ambient Temperature

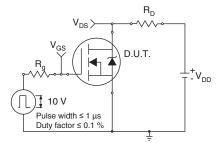


Fig. 10a - Switching Time Test Circuit

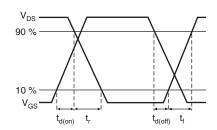


Fig. 10b - Switching Time Waveforms

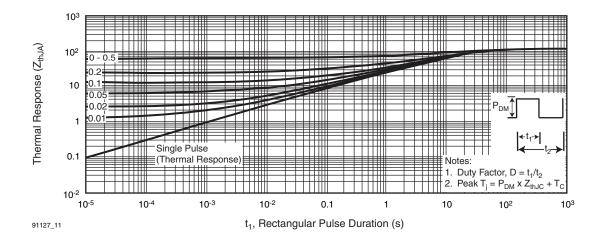


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Ambient



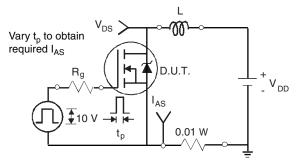


Fig. 12a - Unclamped Inductive Test Circuit

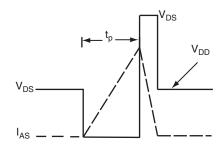


Fig. 12b - Unclamped Inductive Waveforms

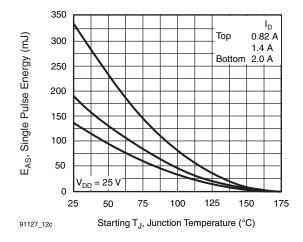


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

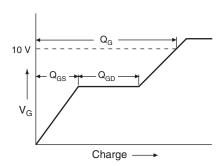


Fig. 13a - Basic Gate Charge Waveform

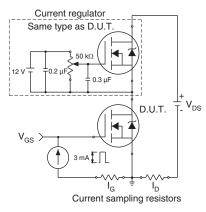
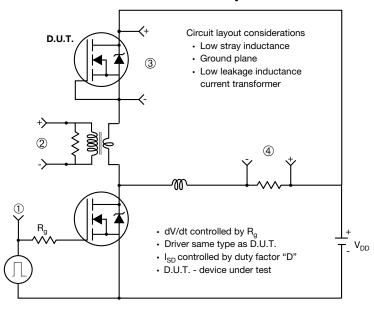


Fig. 13b - Gate Charge Test Circuit





Peak Diode Recovery dV/dt Test Circuit



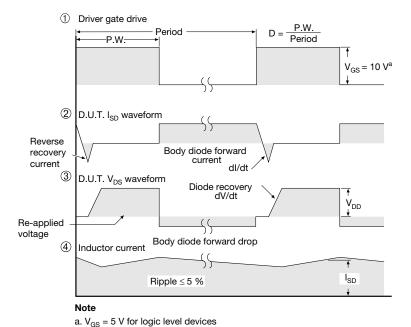
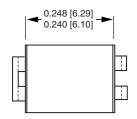
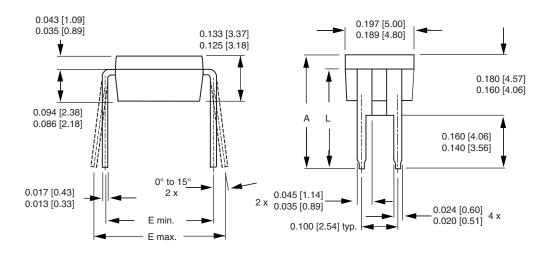


Fig. 14 - For N-Channel

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HVM DIP (High voltage)





| | INCHES | | MILLIMETERS | | |
|------|--------|-------|-------------|-------|--|
| DIM. | MIN. | MAX. | MIN. | MAX. | |
| A | 0.310 | 0.330 | 7.87 | 8.38 | |
| Е | 0.300 | 0.425 | 7.62 | 10.79 | |
| L | 0.270 | 0.290 | 6.86 | 7.36 | |

ECN: X10-0386-Rev. B, 06-Sep-10

DWG: 5974

Note

1. Package length does not include mold flash, protrusions or gate burrs. Package width does not include interlead flash or protrusions.

Document Number: 91361 Revision: 06-Sep-10



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